



SAR TEST REPORT

Product Name	Smart terminal
Model Name	BN-HH-G02
Brand Name	Baynexus
FCC ID	2ABHWBN-HH-G02
Client	BayNexus Inc
Manufacturer	GUANGDONG SIMDO TECHNOLOGY Co.,LTD.
Date of issue	January 13, 2014

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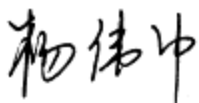
Report No. RXA1310-0177SAR

Page 2 of 64

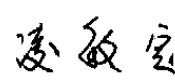
GENERAL SUMMARY

Reference Standard(s)	FCC 47CFR §2.1093 Radiofrequency Radiation Exposure Evaluation: Portable Devices ANSI C95.1, 1992: Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.(IEEE Std C95.1-1991) IEEE Std 1528™-2003: IEEE Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques. KDB 865664 D01 SAR measurement 100 MHz to 6 GHz v01r02: SAR Measurement Requirements for 100 MHz to 6 GHz KDB 447498 D01 General RF Exposure Guidance v05r01: Mobile and Portable Device RF Exposure Procedures and Equipment Authorization Policies KDB 941225 D07 UMPC Mini Tablet v01r01 SAR Evaluation Procedures for UMPC Mini-Tablet Devices
Conclusion	This portable wireless equipment has been measured in all cases requested by the relevant standards. Test results in Chapter 7 of this test report are below limits specified in the relevant standards for the tested bands only. General Judgment: Pass
Comment	The test result only responds to the measured sample.

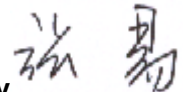
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TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 3 of 64

TABLE OF CONTENT

1. General Information	5
1.1. Notes of the Test Report.....	5
1.2. Testing Laboratory	5
1.3. Applicant Information	6
1.4. Manufacturer Information	6
1.5. Information of EUT	7
1.6. The Maximum Reported SAR _{1g}	8
1.7. Test Date	8
2. SAR Measurements System Configuration	9
2.1. SAR Measurement Set-up	9
2.2. DASY5 E-field Probe System	10
2.2.1. EX3DV4 Probe Specification	10
2.2.2. E-field Probe Calibration	11
2.3. Other Test Equipment	11
2.3.1. Device Holder for Transmitters	11
2.3.2. Phantom	12
2.4. Scanning Procedure	12
2.5. Data Storage and Evaluation	14
2.5.1. Data Storage.....	14
2.5.2. Data Evaluation by SEMCAD	14
3. Laboratory Environment.....	16
4. Tissue-equivalent Liquid	17
4.1. Tissue-equivalent Liquid Ingredients.....	17
4.2. Tissue-equivalent Liquid Properties	18
5. System Check.....	19
5.1. Description of System Check.....	19
5.2. System Check Results	20
6. Operational Conditions during Test	21
6.1. RFID Test Configuration.....	21
6.2. Measurement Variability.....	21
6.3. Test Positions.....	22
6.3.1. Test Positions Requirements	22
7. Test Results	24
7.1. Conducted Power Results	24
7.2. SAR Test Results	25
7.2.1. RFID	25
8. Measurement Uncertainty	26
9. Main Test Instruments	28
ANNEX A: Test Layout	29
ANNEX B: System Check Results	30
ANNEX C: Graph Results	31
ANNEX D: Probe Calibration Certificate	36
ANNEX E: D835V2 Dipole Calibration Certificate	47

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 4 of 64

ANNEX F: DAE4 Calibration Certificate 55

ANNEX G: The EUT Appearances and Test Configuration 60

1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L2264.

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report alone does not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electronic report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

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TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 6 of 64

1.3. Applicant Information

Company: BayNexus Inc
Address: B307,530 Building TaiHu International Science park Wu Xi ,
China

1.4. Manufacturer Information

Company: GUANGDONG SIMDO TECHNOLOGY Co.,LTD.
Address: NORTH OF Second FLOOR, 29 BLDG,THE SECOND INDUSTRIAL BLOCK,MA AN
SHAN,SHAJING STREET,BAOAN DISTHCT,
SHENZHEN,P.R,CHINA

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 7 of 64

1.5. Information of EUT

General Information

Device Type:	Portable Device	
Exposure Category:	Uncontrolled Environment / General Population	
State of Sample:	Prototype Unit	
IMEI:	867572010430023	
Hardware Version:	900C0000000004	
Software Version:	V3.0	
Antenna Type:	Internal Antenna	
Device Operating Configurations:		
Operating Mode(s):	RFID (902-928); (tested)	
Test Modulation:	GMSK;	
Test Channel: (Low - Middle - High)	1 -26 - 52	
Test Frequency Range(s):	Mode	Tx (MHz)
	RFID	902 ~ 928

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 8 of 64

Equipment Under Test (EUT) has an antenna that is used for Tx/Rx.

The sample undergoing test was selected by the Client.

Components list please refer to documents of the manufacturer.

Auxiliary equipment details

AE1: Battery

Model: bl-10c
Manufacturer: BayNexus Inc
S/N: /

1.6. The Maximum Reported SAR_{1g}

Body SAR Configuration

Mode	Test Position	Channel /Frequency(MHz)	Limit SAR _{1g} 1.6 W/kg	
			Measured SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
RFID	Test Position 1/ Back Side	1/902.25	0.498	0.545

1.7. Test Date

The test performed on December 19, 2013.

2. SAR Measurements System Configuration

2.1. SAR Measurement Set-up

The DASY5 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e. an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A data acquisition electronic (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- A unit to operate the optical surface detector which is connected to the EOC.
- The Electro-Optical Coupler (EOC) performs the conversion from the optical into a digital electric signal of the DAE. The EOC is connected to the DASY5 measurement server.
- The DASY5 measurement server, which performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. A computer operating Windows 2003
- DASY5 software and SEMCAD data evaluation software.
- Remote control with teach panel and additional circuitry for robot safety such as warning lamps, etc.
- The generic twin phantom enabling the testing of left-hand and right-hand usage.
- The device holder for handheld mobile phones.
- Tissue simulating liquid mixed according to the given recipes.
- System validation dipoles allowing to validate the proper functioning of the system.

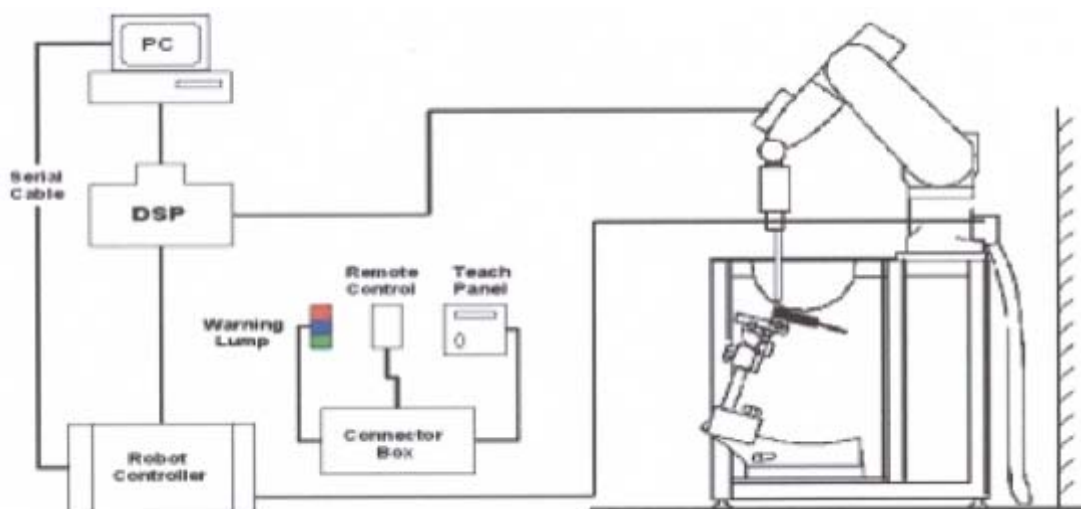


Figure 1. SAR Lab Test Measurement Set-up

2.2. DASY5 E-field Probe System

The SAR measurements were conducted with the dosimetric probe EX3DV4 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

2.2.1. EX3DV4 Probe Specification

Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)
Calibration	ISO/IEC 17025 calibration service available
Frequency	10 MHz to > 6 GHz Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis)
Dynamic Range	10 μ W/g to > 100 mW/g Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm
Application	High precision dosimetric measurements in any exposure scenario (e.g., very strong gradient fields). Only probe which enables compliance testing for frequencies up to 6 GHz with precision of better 30%.



Figure 2. EX3DV4 E-field Probe



Figure 3. EX3DV4 E-field probe

2.2.2. E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than $\pm 10\%$. The spherical isotropy was evaluated and found to be better than $\pm 0.25\text{dB}$. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$\text{SAR} = C \frac{\Delta T}{\Delta t}$$

Where: Δt = Exposure time (30 seconds),

C = Heat capacity of tissue (brain or muscle),

ΔT = Temperature increase due to RF exposure.

Or

$$\text{SAR} = \frac{|E|^2 \sigma}{\rho}$$

Where:

σ = Simulated tissue conductivity,

ρ = Tissue density (kg/m^3).

2.3. Other Test Equipment

2.3.1. Device Holder for Transmitters

Construction: Simple but effective and easy-to-use extension for Mounting Device that facilitates the testing of larger devices according to IEC 62209-2 (e.g., laptops, cameras, etc.) It is lightweight and fits easily on the upper part of the Mounting Device in place of the phone positioner. The extension is fully compatible with the Twin SAM, ELI4 and SAM v6.0 Phantoms.

Material: POM, Acrylic glass, Foam

2.3.2. Phantom

Phantom for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI is fully compatible with the IEC 62209-2 standard and all known tissue simulating liquids. ELI has been optimized regarding its performance and can be integrated into our standard phantom tables. A cover prevents evaporation of the liquid. Reference markings on the phantom allow installation of the complete setup, including all predefined phantom positions and measurement grids, by teaching three points. The phantom is compatible with all SPEAG do symmetric probes and dipoles.

Shell Thickness	2±0.2 mm
Filling Volume	Approx. 30 liters
Dimensions	190×600×0 mm (H x L x W)



Figure 4.ELI4 Phantom

2.4. Scanning Procedure

The DASY5 installation includes predefined files with recommended procedures for measurements and validation. They are read-only document files and destined as fully defined but unmeasured masks. All test positions (head or body-worn) are tested with the same configuration of test steps differing only in the grid definition for the different test positions.

- The “reference” and “drift” measurements are located at the beginning and end of the batch process. They measure the field drift at one single point in the liquid over the complete procedure. The indicated drift is mainly the variation of the DUT’s output power and should vary max. $\pm 5\%$.
- The “surface check” measurement tests the optical surface detection system of the DASY5 system by repeatedly detecting the surface with the optical and mechanical surface detector and comparing the results. The output gives the detecting heights of both systems, the difference between the two systems and the standard deviation of the detection repeatability. Air bubbles or refraction in the liquid due to separation of the sugar-water mixture gives poor repeatability (above $\pm 0.1\text{mm}$). To prevent wrong results tests are only executed when the liquid is free of air bubbles. The difference between the optical surface detection and the actual surface depends on the probe and is specified with each probe. (It does not depend on the surface reflectivity or the probe angle to the surface within $\pm 30^\circ$.)

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 13 of 64

- Area Scan

The Area Scan is used as a fast scan in two dimensions to find the area of high field values before running a detailed measurement around the hot spot. Before starting the area scan a grid spacing is set according to FCC KDB Publication 865664. During scan the distance of the probe to the phantom remains unchanged.

After finishing area scan, the field maxima within a range of 2 dB will be ascertained.

- Zoom Scan

After the maximum interpolated values were calculated between the points in the cube, the SAR was averaged over the spatial volume (1g or 10g) using a 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the “Not a knot” condition (in x, y, and z directions). The volume was then integrated with the trapezoidal algorithm.

- Spatial Peak Detection

The procedure for spatial peak SAR evaluation has been implemented and can determine values of masses of 1g and 10g, as well as for user-specific masses. The DASY5 system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maxima searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation. Extrapolation routines require at least 10 measurement points in 3-D space.

They are used in the Zoom Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the modified Quadratic Shepard's method for extrapolation.

- A Z-axis scan measures the total SAR value at the x-and y-position of the maximum SAR value found during the cube scan. The probe is moved away in z-direction from the bottom of the SAM phantom in 5mm steps.

Table 1: Area and Zoom Scan Resolutions per FCC KDB Publication 865664 D01

Frequency	Maximum Area Scan Resolution (mm) ($\Delta x_{\text{area}}, \Delta y_{\text{area}}$)	Maximum Zoom Scan Resolution (mm) ($\Delta x_{\text{zoom}}, \Delta y_{\text{zoom}}$)	Maximum Zoom Scan Spatial Resolution (mm) $\Delta z_{\text{zoom}}(n)$	Minimum Zoom Scan Volume (mm) (x,y,z)
≤ 2 GHz	≤ 15	≤ 8	≤ 5	≥ 30
2-3 GHz	≤ 12	≤ 5	≤ 5	≥ 30
3-4 GHz	≤ 12	≤ 5	≤ 4	≥ 28
4-5 GHz	≤ 10	≤ 4	≤ 3	≥ 25
5-6 GHz	≤ 10	≤ 4	≤ 2	≥ 22

2.5. Data Storage and Evaluation

2.5.1. Data Storage

The DASY5 software stores the acquired data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files with the extension “.DAE4”. The software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of incorrect parameter settings. For example, if a measurement has been performed with a wrong crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be re-evaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type ([V/m], [A/m], [°C], [mW/g], [mW/cm²], [dBrel], etc.). Some of these units are not available in certain situations or show meaningless results, e.g., a SAR output in a lossless media will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

2.5.2. Data Evaluation by SEMCAD

The SEMCAD software automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, a_{i0} , a_{i1} , a_{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	Dcp _i
Device parameters:	- Frequency	f
	- Crest factor	cf
Media parameters:	- Conductivity	
	- Density	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY5 components. In the direct measuring mode of the multimeter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 15 of 64

If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot c f / d c p_i$$

With V_i = compensated signal of channel i (i = x, y, z)

U_i = input signal of channel i (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

E-field probes: $E_i = (V_i / Norm_i \cdot ConvF)^{1/2}$

H-field probes: $H_i = (V_i)^{1/2} \cdot (a_{i0} + a_{i1} f + a_{i2} f^2) / f$

With V_i = compensated signal of channel i (i = x, y, z)

$Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
[mV/(V/m)²] for E-field Probes

$ConvF$ = sensitivity enhancement in solution

a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i = electric field strength of channel i in V/m

H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = (E_x^2 + E_y^2 + E_z^2)^{1/2}$$

The primary field data are used to calculate the derived field units.

$$SAR = (E_{tot})^2 \cdot \sigma / (\rho \cdot 1000)$$

with SAR = local specific absorption rate in mW/g

E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [Siemens/m]

ρ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid. The power flow density is calculated assuming the excitation field to be a free space field.

$$P_{pwe} = E_{tot}^2 / 3770 \quad \text{or} \quad P_{pwe} = H_{tot}^2 \cdot 37.7$$

with P_{pwe} = equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m

3. Laboratory Environment

Table 2: The Requirements of the Ambient Conditions

Temperature	Min. = 18°C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

4. Tissue-equivalent Liquid

4.1. Tissue-equivalent Liquid Ingredients

The liquid is consisted of water, salt, Glycol, Sugar, Preventol and Cellulose. The liquid has previously been proven to be suited for worst-case. Table 3 shows the detail solution. It's satisfying the latest tissue dielectric parameters requirements proposed by the KDB 865664 D01.

Table 3: Composition of the Body Tissue Equivalent Matter

MIXTURE%	FREQUENCY(Body) 835MHz		
Water	52.5		
Sugar	45		
Salt	1.4		
Preventol	0.1		
Cellulose	1.0		
Dielectric Parameters Target Value	f=835MHz	$\epsilon=55.2$	$\sigma=0.97$

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Test Report

4.2. Tissue-equivalent Liquid Properties

Table 4: Dielectric Performance of Tissue Simulating Liquid

Frequency	Test Date	Temp ℃	Measured Dielectric Parameters		Target Dielectric Parameters		Limit (Within ±5%)	
			ϵ_r	$\sigma(\text{s/m})$	ϵ_r	$\sigma(\text{s/m})$	Dev $\epsilon_r(\%)$	Dev $\sigma(\%)$
835MHz (body)	2013-12-19	21.5	55.1	0.99	55.20	0.97	-0.18	2.06

5. System Check

5.1. Description of System Check

The manufacturer calibrates the probes annually. Dielectric parameters of the tissue simulants were measured every day using the dielectric probe kit and the network analyzer. A system check measurement was made following the determination of the dielectric parameters of the simulant, using the dipole validation kit. A power level of 250 mW was supplied to the dipole antenna, which was placed under the flat section of the twin SAM phantom. The system check results (dielectric parameters and SAR values) are given in the table 5.

System check results have to be equal or near the values determined during dipole calibration with the relevant liquids and test system ($\pm 10\%$).

System check is performed regularly on all frequency bands where tests are performed with the DASY5 system.

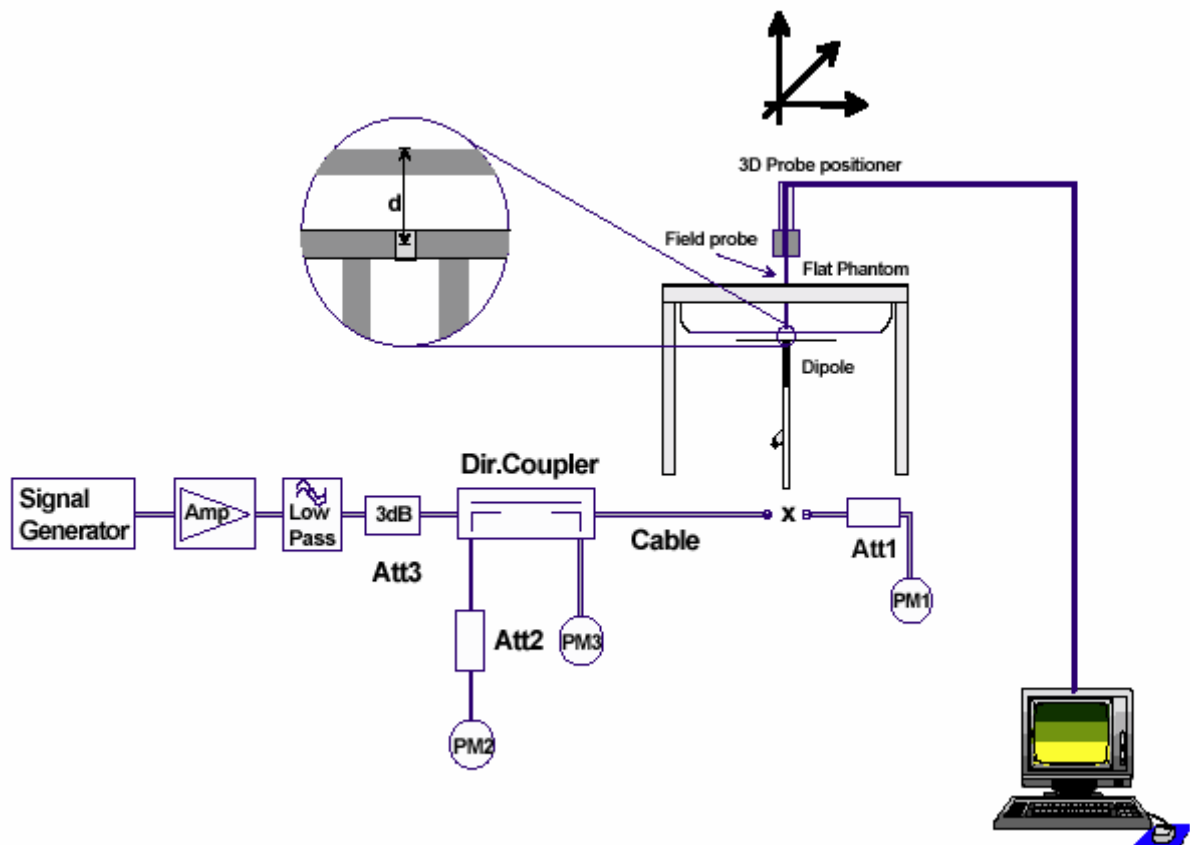


Figure 5. System Check Set-up

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 20 of 64

Justification for Extended SAR Dipole Calibrations

Usage of SAR dipoles calibrated less than 3 years ago but more than 1 year ago were confirmed in maintaining return loss (< -20 dB, within 20% of prior calibration) and impedance (within 5 ohm from prior calibration) requirements per extended calibrations in KDB 865664 D01:

Dipole D835V2 SN: 4d020				
Body Liquid				
Date of Measurement	Return Loss(dB)	Δ %	Impedance (Ω)	$\Delta\Omega$
8/26/2011	-25.1	/	48.7	/
8/25/2012	-24.3	3.2%	50.6	1.9 Ω
8/24/2013	-24.7	1.6%	51.1	2.4 Ω

5.2. System Check Results

Table 5: System Check in Body Tissue Simulating Liquid

Frequency	Test Date	Dielectric Parameters		Temp	250mW Measured SAR _{1g}	1W Normalized SAR _{1g}	1W Target SAR _{1g}	Limit (±10% Deviation)
		ε _r	σ(s/m)	(°C)	(W/kg)			
835MHz	2013-12-19	55.1	0.99	21.5	2.52	10.08	9.46	6.55

Note: 1. The graph results see ANNEX B.

2. Target Values used derive from the calibration certificate

6. Operational Conditions during Test

6.1. RFID Test Configuration

For RFID SAR testing, RFID engineering testing software installed on the EUT can provide continuous transmitting RF signal with maximum output power. This RF signal utilized in SAR measurement has Almost 100% duty cycle and its crest factor is 1.22.

6.2. Measurement Variability

Per FCC KDB Publication 865664 D01, SAR measurement variability was assessed for each frequency band, which was determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media were required for SAR measurements in a frequency band, the variability measurement procedures were applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. These additional measurements were repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device was returned to ambient conditions (normal room temperature) with the battery fully charged before it was re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR Measurement Variability was assessed using the following procedures for each frequency band:

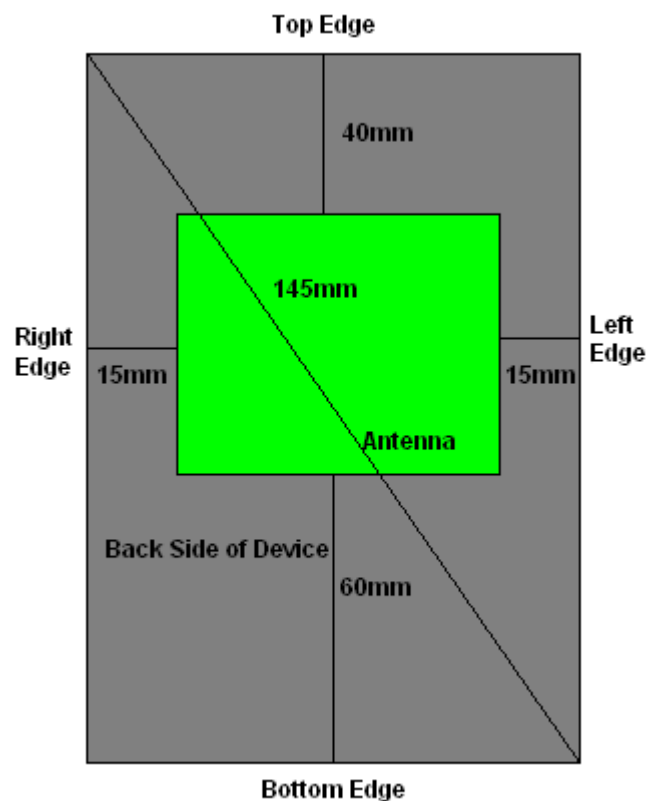
- 1) When the original highest measured SAR is ≥ 0.80 W/kg, the measurement was repeated once.
- 2) A second repeated measurement was performed only if the ratio of largest to smallest SAR for the original and first repeated measurements was > 1.20 or when the original or repeated measurement was ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).
- 3) A third repeated measurement was performed only if the original, first or second repeated measurement was ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20 .
- 4) Repeated measurements are not required when the original highest measured SAR is < 0.80 W/kg

6.3. Test Positions

6.3.1. Test Positions Requirements

According to KDB inquiry, we tested based upon KDB941225 D07 with a overall diagonal dimension $14.5\text{cm} \leq 20\text{ cm}$.

The device must be tested for 1-g SAR on all surfaces and side edges with a transmitting antenna located at $\leq 25\text{ mm}$ from that surface or edge, at 0 mm separation from a flat phantom. SAR evaluation for the front surface of tablet display screens are generally not necessary.



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 23 of 64

- Test Position 1: The back surface of the EUT towards to the bottom of the flat phantom. (ANNEX G Picture 4). SAR is required for RFID antenna in this position.

- Test Position 2: The left edge of the EUT towards the bottom of the flat phantom. (ANNEX G Picture 5). SAR is required for RFID antenna in this position.

- Test Position 3: The right edge of the EUT towards the bottom of the flat phantom. (ANNEX G Picture 6). SAR is required for RFID antenna in this position.

- Test Position 4: The top edge of the EUT towards the bottom of the flat phantom. (ANNEX G Picture 7). SAR is required for RFID antenna in this position.

- Test Position 5: The bottom edge of the EUT towards the bottom of the flat phantom. (ANNEX G Picture 8). SAR is not required for RFID antenna in this position.

7. Test Results

7.1. Conducted Power Results

Table 6: Conducted Power Measurement Results

RFID	Conducted Power (dBm)		
	Channel 1	Channel 26	Channel 52
GFSK	20.61	19.74	19.62

Page 25 of 64

2. Per FCC KDB Publication 447498 D01, if the reported (scaled) SAR measured at the middle channel or highest output power channel for each test configuration is ≤ 0.8 W/kg then testing at the other channels is not required for such test configuration(s).

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 26 of 64

8. Measurement Uncertainty

No.	source	Type	Uncertainty Value (%)	Probability Distribution	k	c _i	Standard uncertainty u_i (%)	Degree of freedom V_{eff} or v_i
1	System repetivity	A	0.5	N	1	1	0.5	9
Measurement system								
2	-probe calibration	B	6.0	N	1	1	6.0	∞
3	-axial isotropy of the probe	B	4.7	R	$\sqrt{3}$	$\sqrt{0.5}$	1.9	∞
4	- Hemispherical isotropy of the probe	B	9.4	R	$\sqrt{3}$	$\sqrt{0.5}$	3.9	∞
5	-boundary effect	B	1.9	R	$\sqrt{3}$	1	1.1	∞
6	-probe linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
7	- System detection limits	B	1.0	R	$\sqrt{3}$	1	0.6	∞
8	-readout Electronics	B	1.0	N	1	1	1.0	∞
9	-response time	B	0.8	R	$\sqrt{3}$	1	0.5	∞
10	-integration time	B	4.3	R	$\sqrt{3}$	1	2.5	∞
11	-RF Ambient noise	B	3.0	R	$\sqrt{3}$	1	1.7	∞
12	-RF Ambient Conditions	B	3.0	R	$\sqrt{3}$	1	1.7	∞
13	-Probe Positioner Mechanical Tolerance	B	0.4	R	$\sqrt{3}$	1	0.2	∞
14	-Probe Positioning with respect to Phantom Shell	B	2.9	R	$\sqrt{3}$	1	1.7	∞
15	-Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	B	3.9	R	$\sqrt{3}$	1	2.3	∞
Test sample Related								
16	-Test Sample Positioning	A	2.9	N	1	1	2.9	71
17	-Device Holder Uncertainty	A	4.1	N	1	1	4.1	5
18	- Power drift	B	5.0	R	$\sqrt{3}$	1	2.9	∞
Physical parameter								
19	-phantom Uncertainty	B	4.0	R	$\sqrt{3}$	1	2.3	∞
20	Algorithm for correcting SAR for deviations in permittivity and conductivity	B	1.9	N	1	0.84	0.9	∞

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 27 of 64

21	-Liquid conductivity (measurement uncertainty)	B	2.5	N	1	0.71	1.8	9
22	-Liquid permittivity (measurement uncertainty)	B	2.5	N	1	0.26	0.7	9
23	-Liquid conductivity -temperature uncertainty	B	1.7	R	$\sqrt{3}$	0.71	0.7	∞
24	-Liquid permittivity -temperature uncertainty	B	0.3	R	$\sqrt{3}$	0.26	0.05	∞
Combined standard uncertainty		$u_c' = \sqrt{\sum_{i=1}^{24} c_i^2 u_i^2}$					11.34	
Expanded uncertainty (confidence interval of 95 %)		$u_e = 2u_c$		N	k=2		22.68	

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 28 of 64

9. Main Test Instruments

Table 8: List of Main Instruments

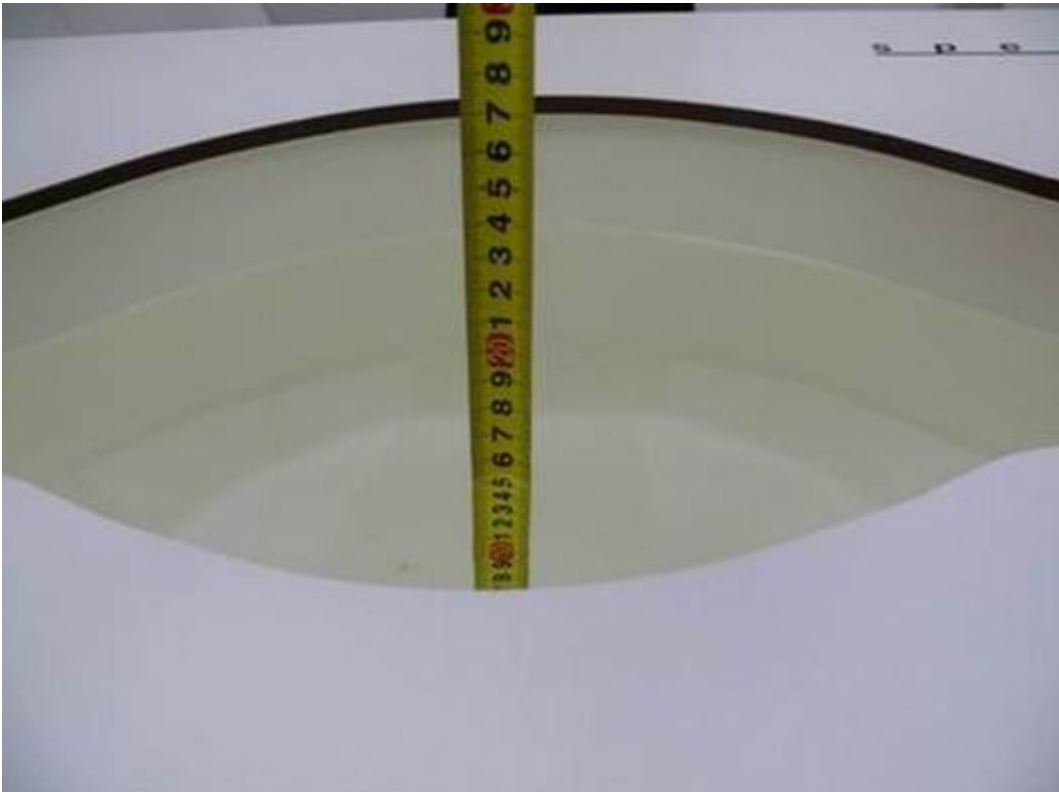
No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Network analyzer	Agilent 8753E	US37390326	September 9, 2013	One year
02	Dielectric Probe Kit	Agilent 85070E	US44020115	No Calibration Requested	
03	Power meter	Agilent E4417A	GB41291714	March 10, 2013	One year
04	Power sensor	Agilent N8481H	MY50350004	September 23, 2013	One year
05	Power sensor	E9327A	US40441622	January 2, 2013	One year
06	Signal Generator	HP 8341B	2730A00804	September 9, 2013	One year
07	Dual directional coupler	778D-012	50519	March 25, 2013	One year
08	Amplifier	IXA-020	0401	No Calibration Requested	
09	E-field Probe	EX3DV4	3753	January 17, 2013	One year
10	DAE	DAE4	1317	January 25, 2013	One year
11	Validation Kit 835MHz	D835V2	4d020	August 26, 2011	Three years
12	Temperature Probe	JM222	AA1009129	March 14, 2013	One year
13	Hygrothermograph	WS-1	64591	September 26, 2013	One year

*****END OF REPORT *****

ANNEX A: Test Layout



Picture 1: Specific Absorption Rate Test Layout



Picture 2: Liquid depth in the Flat Phantom (835 MHz, 15.2cm depth)

ANNEX B: System Check Results

System Performance Check at 835 MHz

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Date/Time: 12/19/2013 3:24:37 PM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 55.1$; $\rho = 1000 \text{ kg/m}^3$

Ambient Temperature: 22.3°C Liquid Temperature: 21.5°C

Phantom section: Flat Section

DASY5 Configuration:

Probe: EX3DV4 - SN3753; ConvF(9.05, 9.05, 9.05); Calibrated: 1/17/2013

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Sensor-Surface: 4mm (Mechanical Surface Detection)

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

d=15mm, Pin=250mW/Area Scan (61x121x1): Measurement grid: $dx=15\text{mm}$, $dy=15\text{mm}$

Maximum value of SAR (interpolated) = 2.72 mW/g

d=15mm, Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: $dx=8\text{mm}$, $dy=8\text{mm}$, $dz=5\text{mm}$

Reference Value = 50.9 V/m ; Power Drift = 0.023 dB

Peak SAR (extrapolated) = 3.63 W/kg

SAR(1 g) = 2.52 mW/g ; SAR(10 g) = 1.65 mW/g

Maximum value of SAR (measured) = 2.73 mW/g

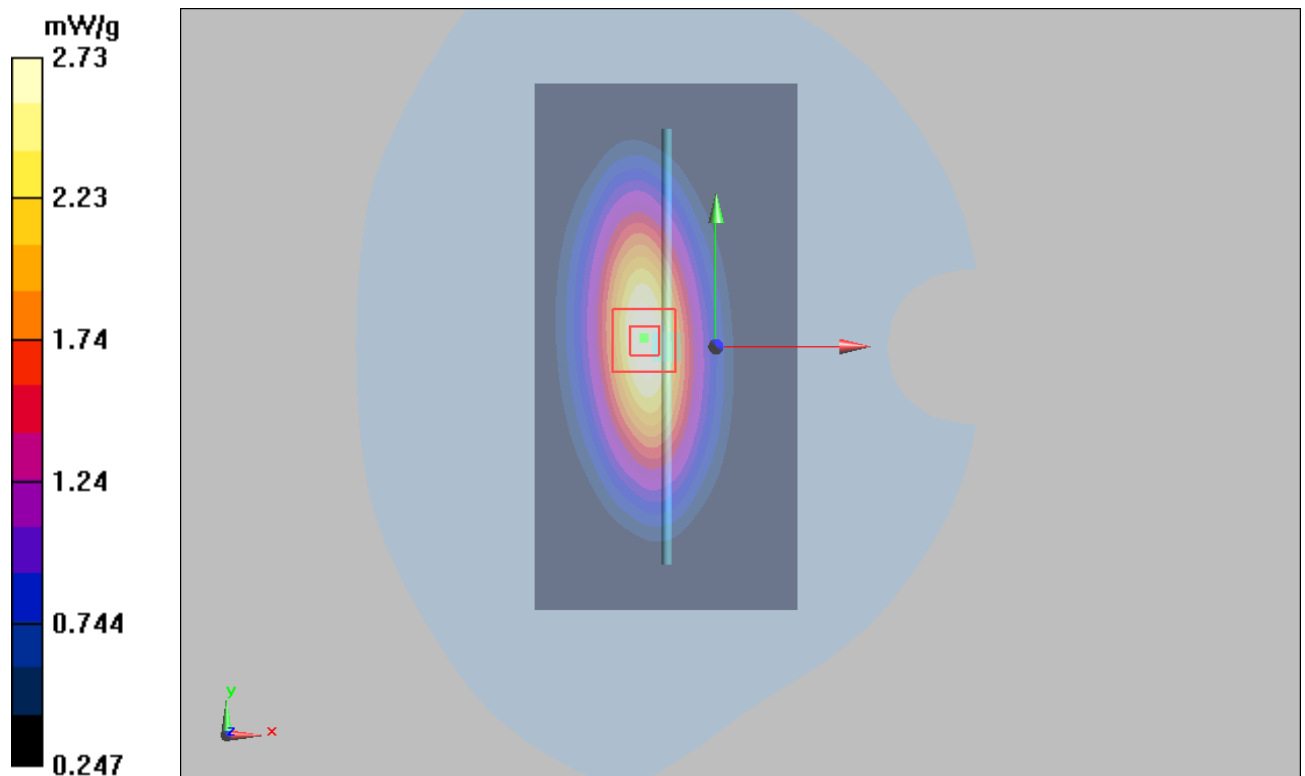


Figure 6 System Performance Check 835MHz 250mW

ANNEX C: Graph Results

RFID Test Position 1 Low

Date/Time: 12/19/2013 5:12:33 PM

Communication System: BT; Frequency: 902.25 MHz; Duty Cycle: 1:1.21955

Medium parameters used (interpolated): $f = 902.25$ MHz; $\sigma = 1.06$ mho/m; $\epsilon_r = 54.429$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3753; ConvF(9.05, 9.05, 9.05); Calibrated: 1/17/2013

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.6 (6824)

Test Position 1 Low /Area Scan (61x111x1): Interpolated grid: dx=15 mm, dy=15 mm

Maximum value of SAR (interpolated) = 0.545 W/kg

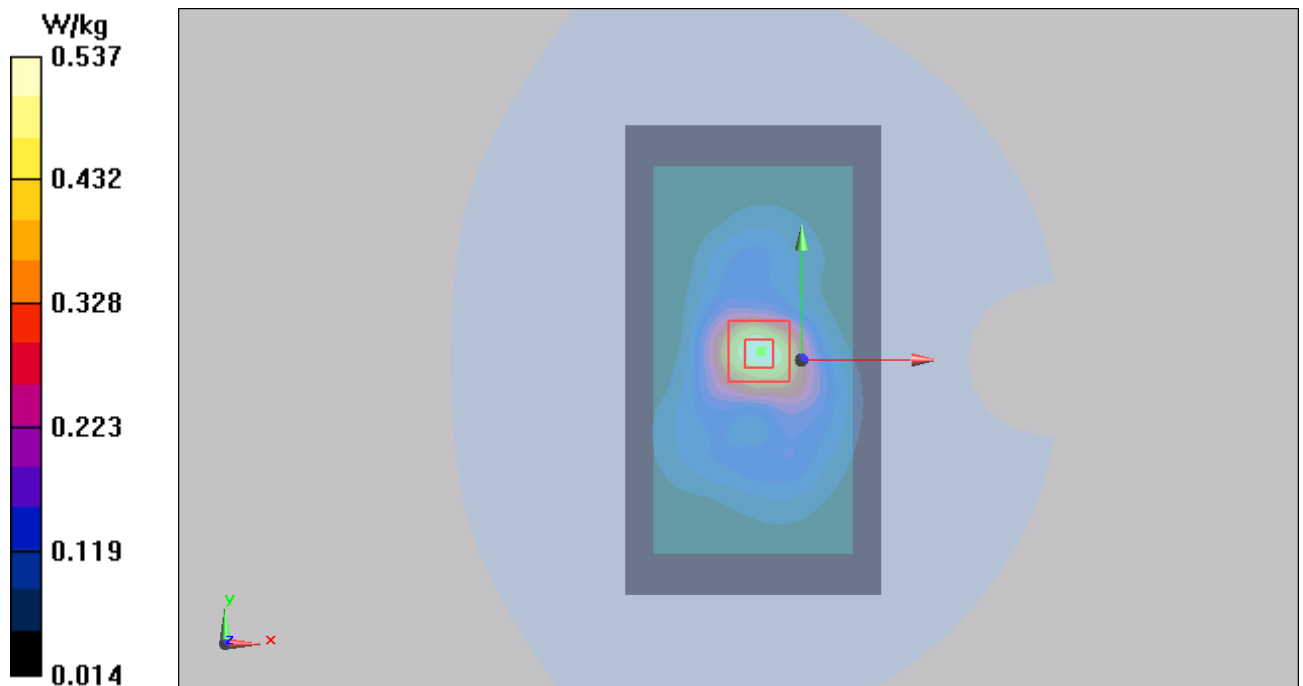
Test Position 1 Low /Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 22.365 V/m; Power Drift = -0.001 dB

Peak SAR (extrapolated) = 0.736 mW/g

SAR(1 g) = 0.498 mW/g; SAR(10 g) = 0.297 mW/g

Maximum value of SAR (measured) = 0.537 W/kg



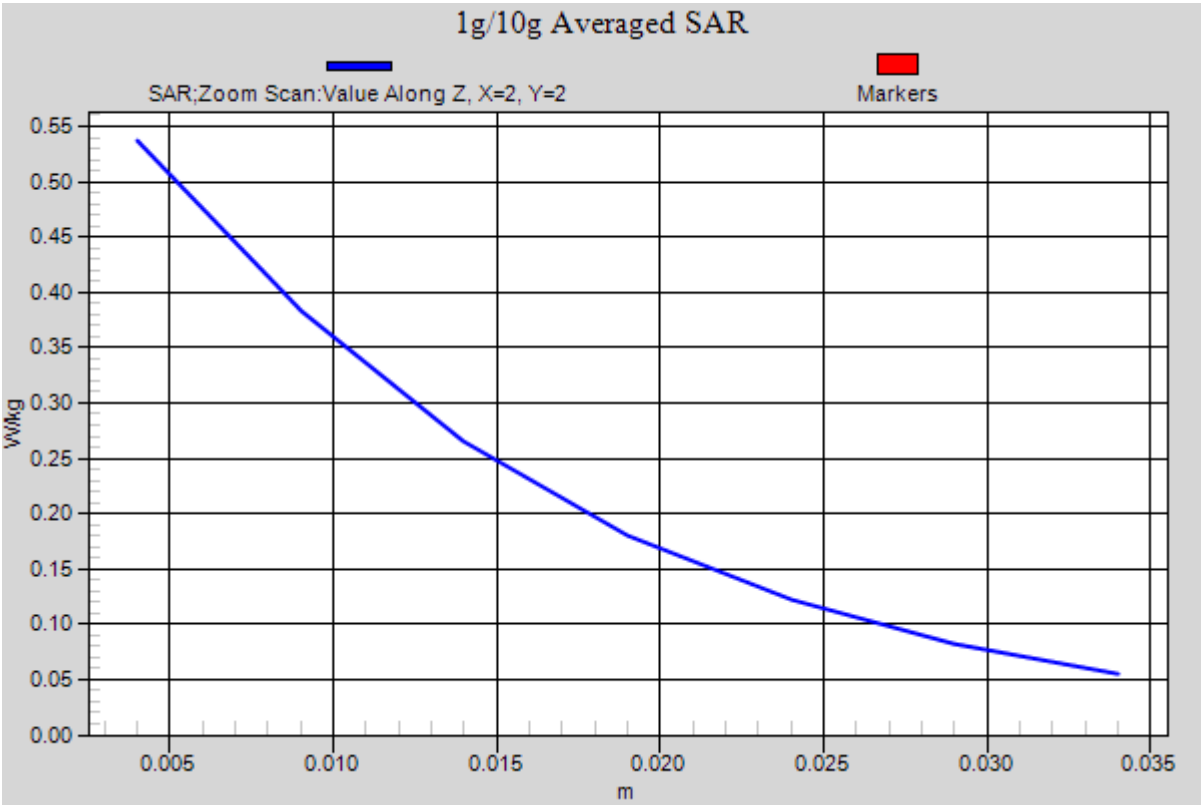


Figure 7 RFID Test Position 1 Channel 1

RFID Test Position 2 Low

Date/Time: 12/19/2014 5:38:38 PM

Communication System: BT; Frequency: 902.25 MHz; Duty Cycle: 1:1.21955

Medium parameters used (interpolated): $f = 902.25$ MHz; $\sigma = 1.06$ mho/m; $\epsilon_r = 54.429$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3753; ConvF(9.05, 9.05, 9.05); Calibrated: 1/17/2013

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.6 (6824)

Test Position 2 Low /Area Scan (41x111x1): Interpolated grid: dx=10 mm, dy=10 mm

Maximum value of SAR (interpolated) = 0.0847 W/kg

Test Position 2 Low /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 8.814 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 0.114 mW/g

SAR(1 g) = 0.078 mW/g; SAR(10 g) = 0.050 mW/g

Maximum value of SAR (measured) = 0.0832 W/kg

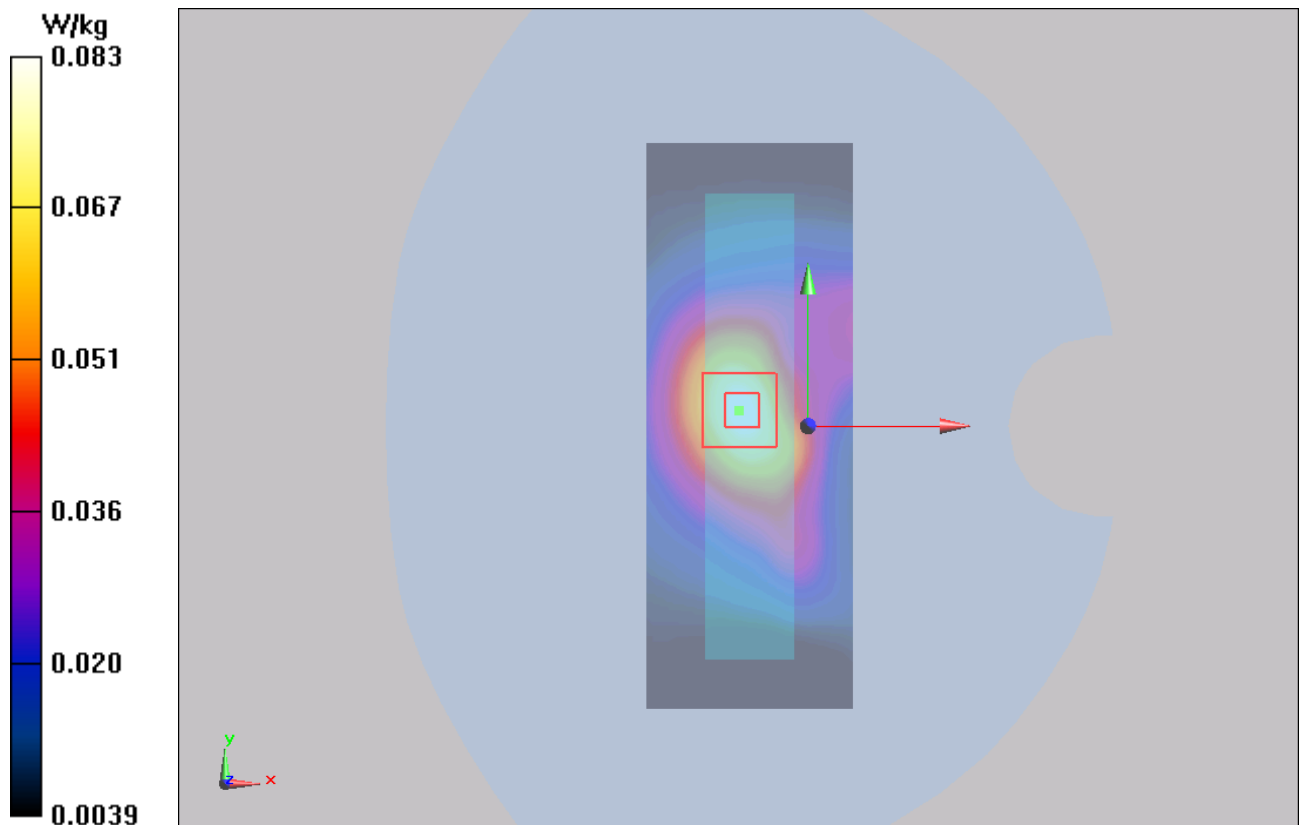


Figure 8 RFID Test Position 2 Channel 1

RFID Test Position 3 Low

Date/Time: 12/19/2013 6:13:19 PM

Communication System: BT; Frequency: 902.25 MHz; Duty Cycle: 1:1.21955

Medium parameters used (interpolated): $f = 902.25$ MHz; $\sigma = 1.06$ mho/m; $\epsilon_r = 54.429$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3753; ConvF(9.05, 9.05, 9.05); Calibrated: 1/17/2013

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.6 (6824)

Test Position 3 Low /Area Scan (41x111x1): Interpolated grid: dx=10 mm, dy=10 mm

Maximum value of SAR (interpolated) = 0.0936 W/kg

Test Position 3 Low /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 9.299 V/m; Power Drift = -0.02 dB

Peak SAR (extrapolated) = 0.120 mW/g

SAR(1 g) = 0.086 mW/g; SAR(10 g) = 0.059 mW/g

Maximum value of SAR (measured) = 0.0918 W/kg

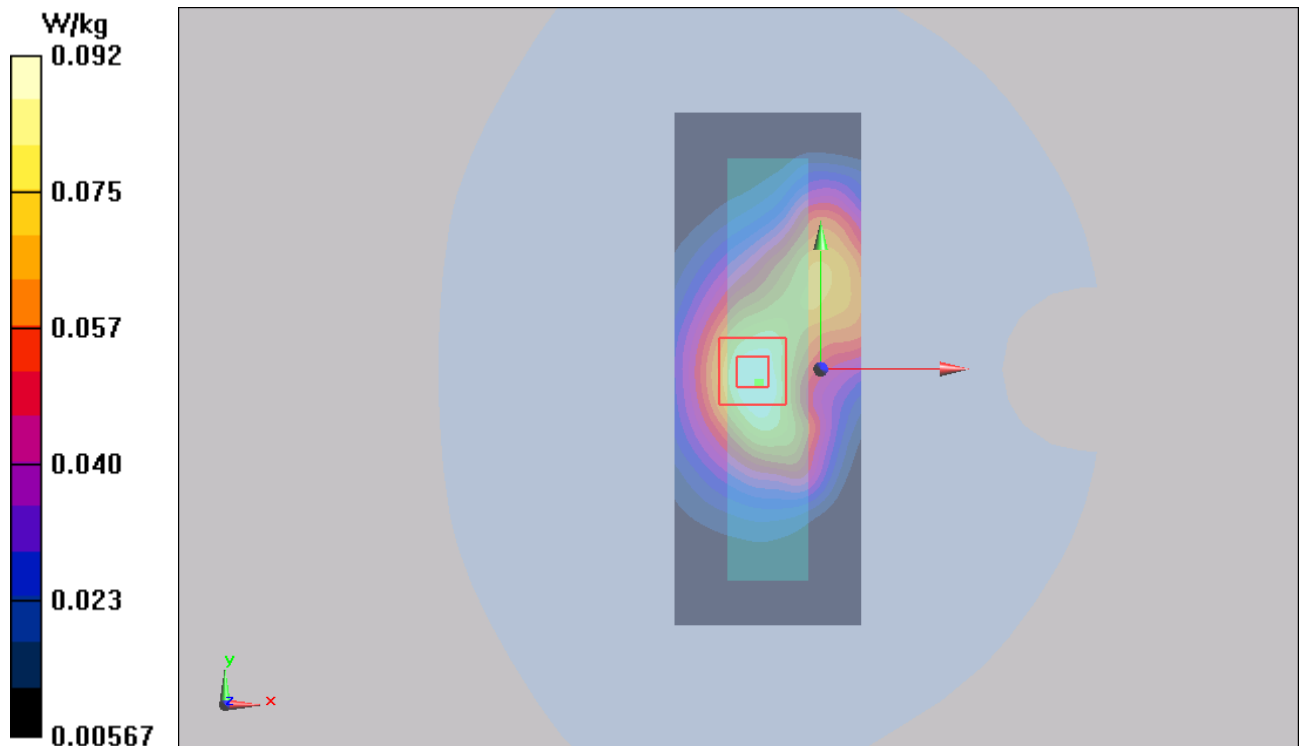


Figure 9 RFID Test Position 3 Channel 1

RFID Test Position 4 Low

Date/Time: 12/19/2013 6:36:13 PM

Communication System: BT; Frequency: 902.25 MHz; Duty Cycle: 1:1.21955

Medium parameters used (interpolated): $f = 902.25$ MHz; $\sigma = 1.06$ mho/m; $\epsilon_r = 54.429$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: Flat Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: EX3DV4 - SN3753; ConvF(9.05, 9.05, 9.05); Calibrated: 1/17/2013

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: SAM1; Type: SAM; Serial: TP-1534

Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.6 (6824)

Test Position 4 Low /Area Scan (31x61x1): Interpolated grid: dx=10 mm, dy=10 mm

Maximum value of SAR (interpolated) = 0.0199 W/kg

Test Position 4 Low /Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 3.991 V/m; Power Drift = 0.020 dB

Peak SAR (extrapolated) = 0.028 mW/g

SAR(1 g) = 0.018 mW/g; SAR(10 g) = 0.012 mW/g

Maximum value of SAR (measured) = 0.0201 W/kg

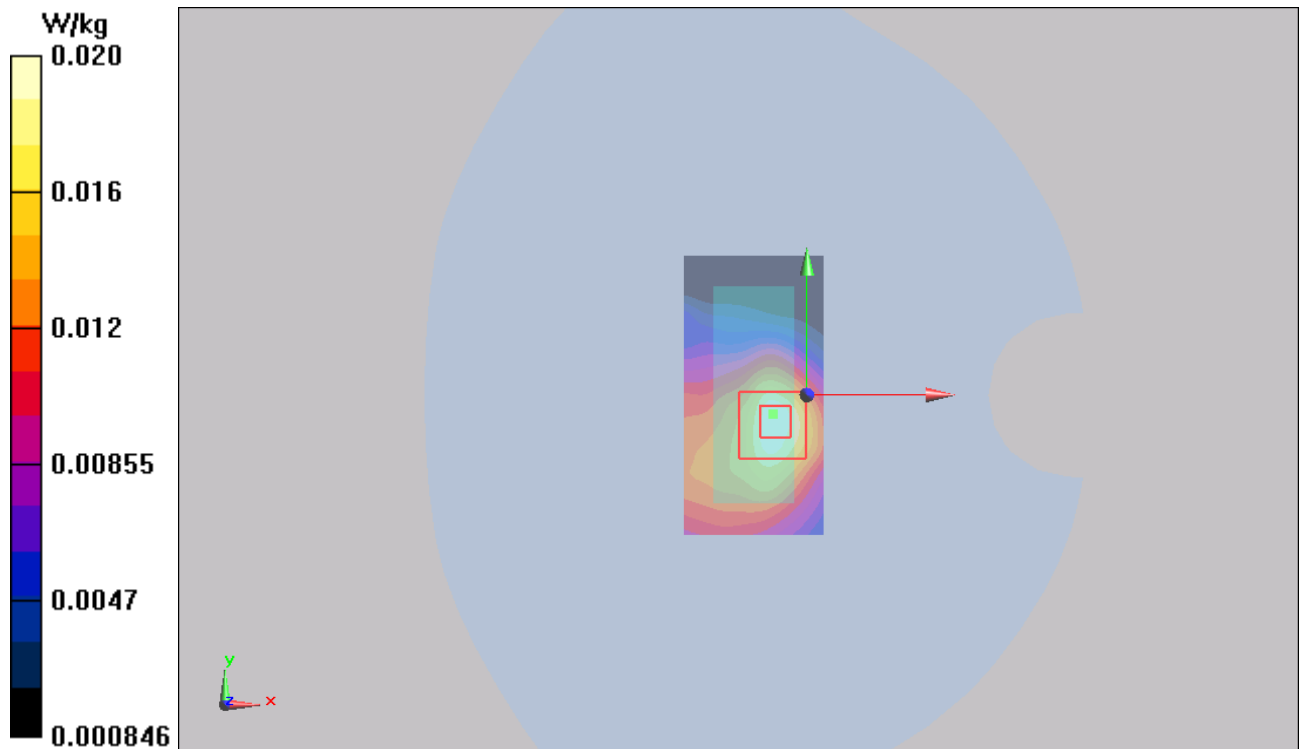


Figure 10 RFID Test Position 4 Channel 1

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 36 of 64

ANNEX D: Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **Auden**

Certificate No: **EX3-3753_Jan13**

CALIBRATION CERTIFICATE

Object **EX3DV4 - SN:3753**

Calibration procedure(s) **QA CAL-01.v8, QA CAL-14.v3, QA CAL-23.v4, QA CAL-25.v4**
Calibration procedure for dosimetric E-field probes

Calibration date: **January 17, 2013**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe ES3DV2	SN: 3013	28-Dec-12 (No. ES3-3013_Dec12)	Dec-13
DAE4	SN: 660	20-Jun-12 (No. DAE4-660_Jun12)	Jun-13
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-12)	In house check: Oct-13

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	
Issued: January 17, 2013			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E^2 -field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

EX3DV4 – SN:3753

January 17, 2013

Probe EX3DV4

SN:3753

Manufactured: March 16, 2010
Calibrated: January 17, 2013

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 39 of 64

EX3DV4- SN:3753

January 17, 2013

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3753

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.47	0.31	0.45	± 10.1 %
DCP (mV) ^B	101.8	102.3	102.3	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	163.7	±3.5 %
		Y	0.0	0.0	1.0		168.5	
		Z	0.0	0.0	1.0		159.9	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 40 of 64

EX3DV4– SN:3753

January 17, 2013

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3753

Calibration Parameter Determined in Head Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha	Depth (mm)	Unct. (k=2)
750	41.9	0.89	9.46	9.46	9.46	0.45	0.83	± 12.0 %
835	41.5	0.90	8.95	8.95	8.95	0.26	1.19	± 12.0 %
1750	40.1	1.37	7.86	7.86	7.86	0.52	0.79	± 12.0 %
1900	40.0	1.40	7.63	7.63	7.63	0.54	0.73	± 12.0 %
2000	40.0	1.40	7.50	7.50	7.50	0.53	0.77	± 12.0 %
2450	39.2	1.80	6.86	6.86	6.86	0.44	0.80	± 12.0 %
5200	36.0	4.66	4.65	4.65	4.65	0.40	1.80	± 13.1 %
5300	35.9	4.76	4.48	4.48	4.48	0.40	1.80	± 13.1 %
5500	35.6	4.96	4.46	4.46	4.46	0.40	1.80	± 13.1 %
5600	35.5	5.07	4.51	4.51	4.51	0.35	1.80	± 13.1 %
5800	35.3	5.27	4.36	4.36	4.36	0.45	1.80	± 13.1 %

^C Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 41 of 64

EX3DV4- SN:3753

January 17, 2013

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3753

Calibration Parameter Determined in Body Tissue Simulating Media

f (MHz) ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha	Depth (mm)	Unct. (k=2)
750	55.5	0.96	9.25	9.25	9.25	0.54	0.75	± 12.0 %
835	55.2	0.97	9.05	9.05	9.05	0.68	0.68	± 12.0 %
1750	53.4	1.49	7.82	7.82	7.82	0.50	0.84	± 12.0 %
1900	53.3	1.52	7.33	7.33	7.33	0.31	1.01	± 12.0 %
2000	53.3	1.52	7.43	7.43	7.43	0.57	0.73	± 12.0 %
2300	52.9	1.81	7.07	7.07	7.07	0.74	0.64	± 12.0 %
2450	52.7	1.95	6.90	6.90	6.90	0.80	0.50	± 12.0 %
2600	52.5	2.16	6.66	6.66	6.66	0.80	0.50	± 12.0 %
3500	51.3	3.31	6.30	6.30	6.30	0.38	1.11	± 13.1 %
5200	49.0	5.30	4.38	4.38	4.38	0.50	1.90	± 13.1 %
5300	48.9	5.42	4.13	4.13	4.13	0.50	1.90	± 13.1 %
5500	48.6	5.65	4.09	4.09	4.09	0.50	1.90	± 13.1 %
5600	48.5	5.77	4.10	4.10	4.10	0.45	1.90	± 13.1 %
5800	48.2	6.00	4.02	4.02	4.02	0.55	1.90	± 13.1 %

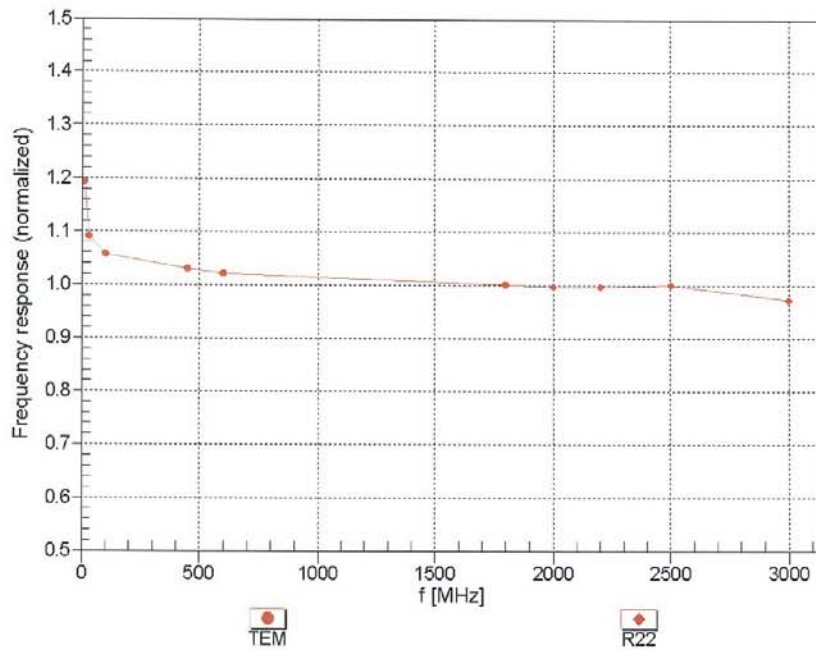
^C Frequency validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ± 50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

^F At frequencies below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ± 10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ± 5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

EX3DV4- SN:3753

January 17, 2013

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)

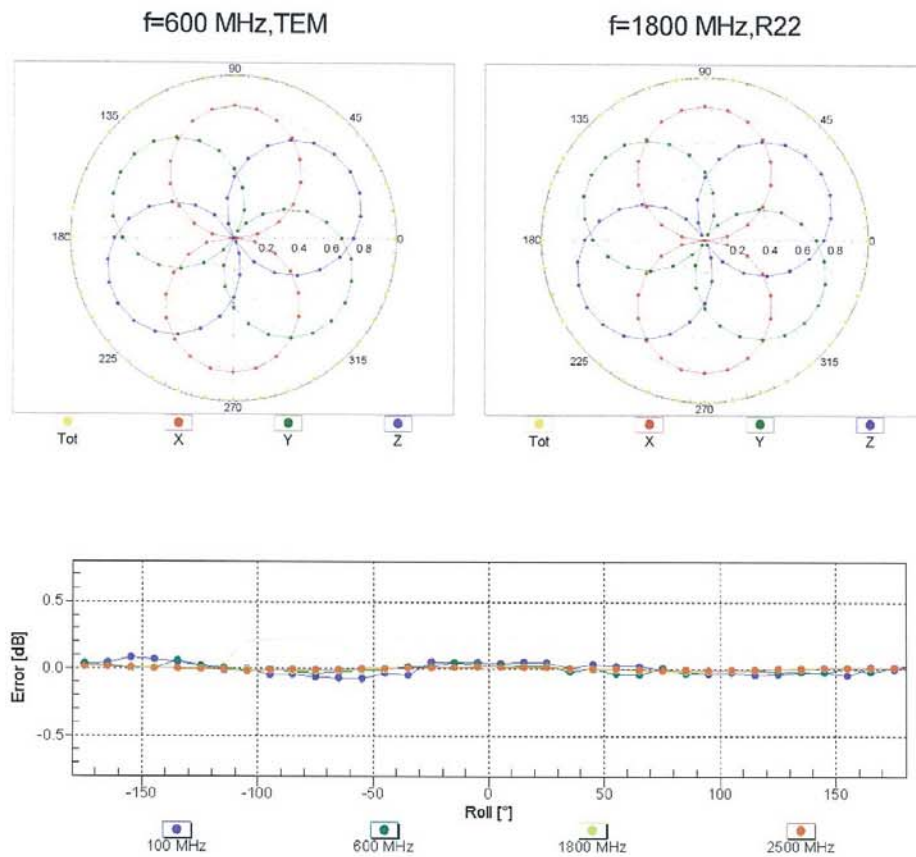


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

EX3DV4—SN:3753

January 17, 2013

Receiving Pattern (ϕ), $\theta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

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Test Report

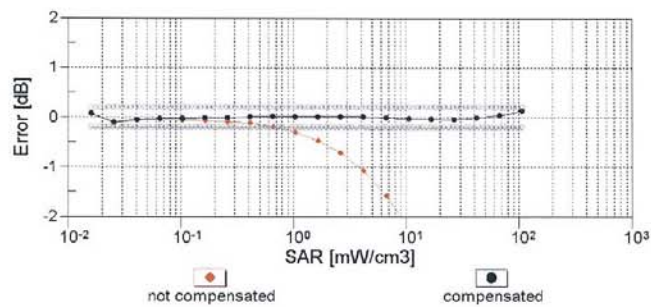
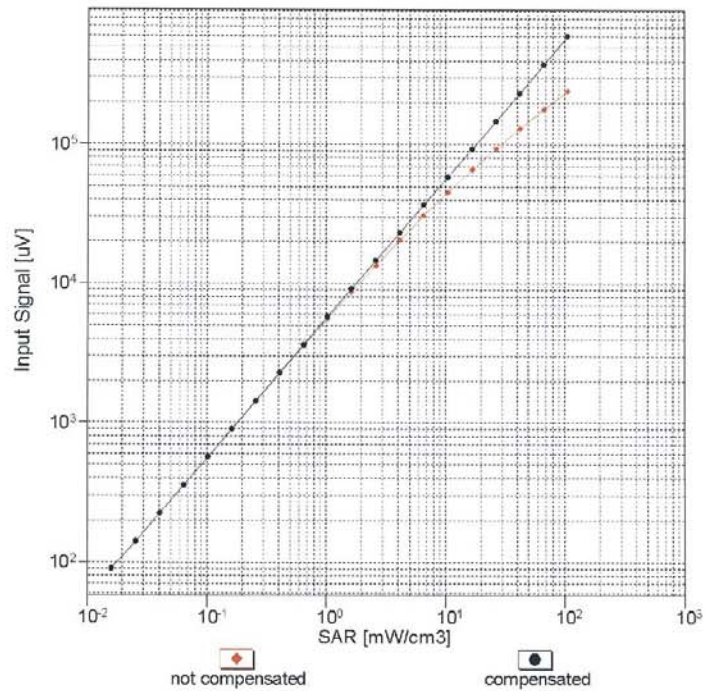
Report No. RXA1310-0177SAR

Page 44 of 64

EX3DV4- SN:3753

January 17, 2013

Dynamic Range f(SAR_{head}) (TEM cell , f = 900 MHz)

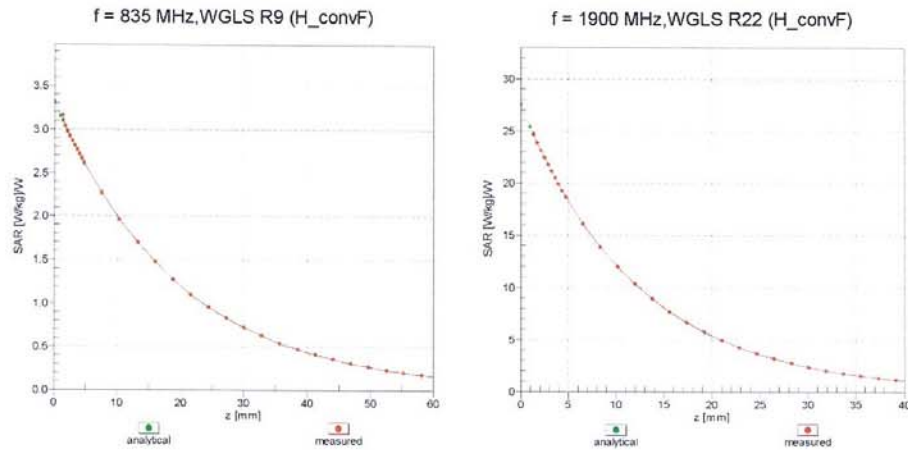


Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

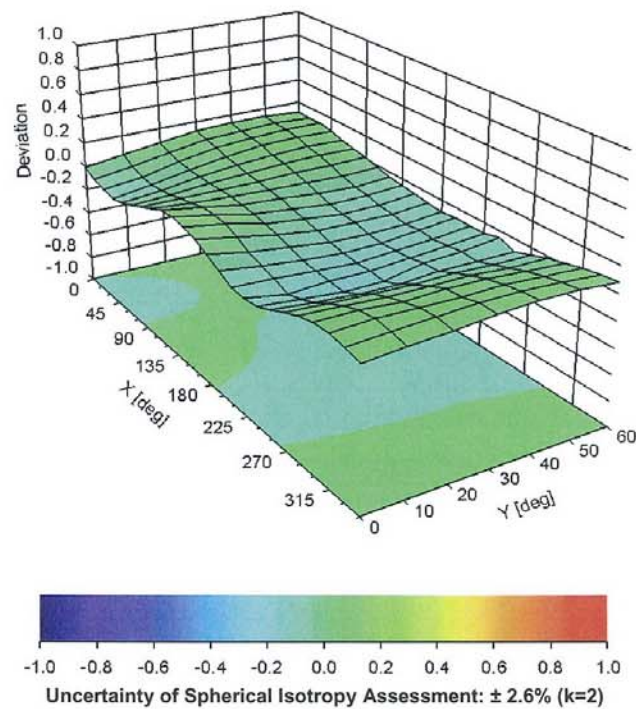
EX3DV4- SN:3753

January 17, 2013

Conversion Factor Assessment



Deviation from Isotropy in Liquid Error (ϕ, ϑ), $f = 900 \text{ MHz}$



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 46 of 64

EX3DV4- SN:3753

January 17, 2013

DASY/EASY - Parameters of Probe: EX3DV4 - SN:3753

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	55.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm

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Test Report

Report No. RXA1310-0177SAR

Page 47 of 64

ANNEX E: D835V2 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Swiss Calibration Service

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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA-Shanghai (Auden)**

Certificate No: **D835V2-4d020_Aug11**

CALIBRATION CERTIFICATE

Object **D835V2 - SN: 4d020**

Calibration procedure(s) **QA CAL-05.v8**
Calibration procedure for dipole validation kits above 700 MHz

Calibration date: **August 26, 2011**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
Power sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
Reference 20 dB Attenuator	SN: S5086 (20b)	29-Mar-11 (No. 217-01367)	Apr-12
Type-N mismatch combination	SN: 5047.2 / 06327	29-Mar-11 (No. 217-01371)	Apr-12
Reference Probe ES3DV3	SN: 3205	29-Apr-11 (No. ES3-3205_Apr11)	Apr-12
DAE4	SN: 601	04-Jul-11 (No. DAE4-601_Jul11)	Jul-12
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100006	04-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

Calibrated by: **Jeton Kastrati** **Laboratory Technician**

Approved by: **Katja Pokovic** **Technical Manager**

Issued: August 26, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D835V2-4d020_Aug11

Page 1 of 8

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 48 of 64

**Calibration Laboratory of
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Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 49 of 64

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz $\pm$ 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 $\pm$ 0.2) °C	41.1 $\pm$ 6 %	0.89 mho/m $\pm$ 6 %
Head TSL temperature change during test	< 0.5 °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.32 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.34 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.52 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.11 mW / g $\pm$ 16.5 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 $\pm$ 0.2) °C	53.4 $\pm$ 6 %	0.99 mho/m $\pm$ 6 %
Body TSL temperature change during test	< 0.5 °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.42 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	9.46 mW / g $\pm$ 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	1.59 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	6.26 mW / g $\pm$ 16.5 % (k=2)

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 50 of 64

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.9 Ω - 3.1 j Ω
Return Loss	- 27.7 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.7 Ω - 5.4 j Ω
Return Loss	- 25.1 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.391 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	April 22, 2004

DASY5 Validation Report for Head TSL

Date: 25.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.89 \text{ mho/m}$; $\epsilon_r = 41.1$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.07, 6.07, 6.07); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Head Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

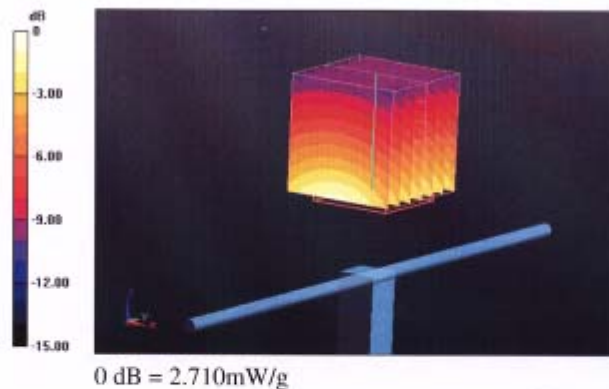
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 56.930 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 3.421 W/kg

SAR(1 g) = 2.32 mW/g; SAR(10 g) = 1.52 mW/g

Maximum value of SAR (measured) = 2.708 mW/g

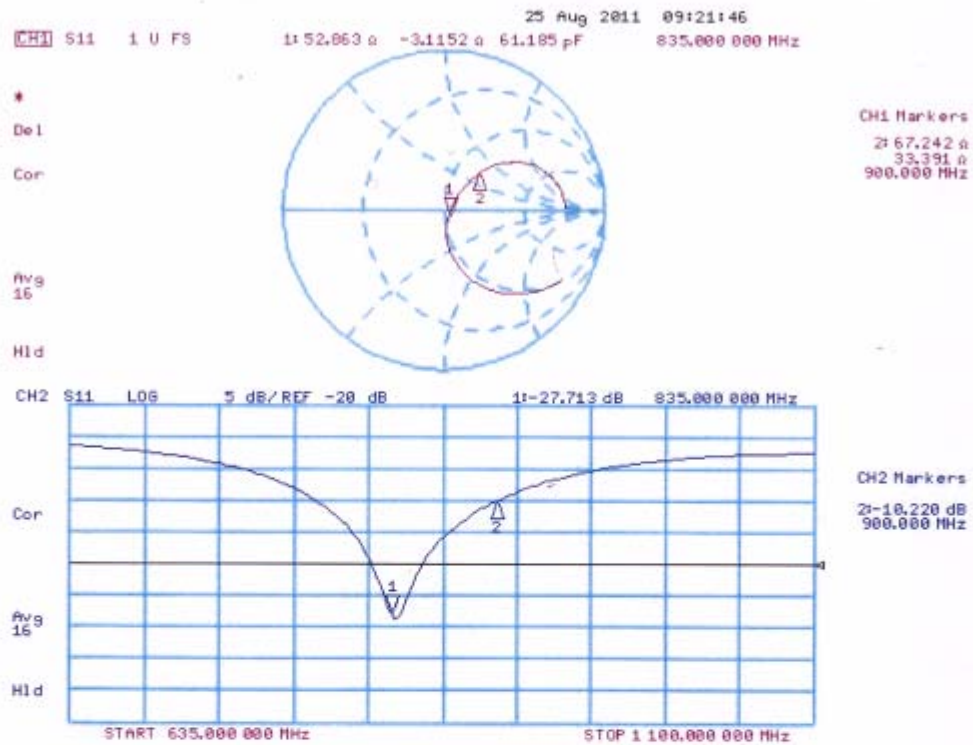


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Test Report

Report No. RXA1310-0177SAR

Page 52 of 64

Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date: 26.08.2011

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d020

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 53.4$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(6.02, 6.02, 6.02); Calibrated: 29.04.2011
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 04.07.2011
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- DASY52 52.6.2(482); SEMCAD X 14.4.5(3634)

Dipole Calibration for Body Tissue/Pin=250 mW, d=15mm/Zoom Scan (7x7x7)/Cube 0:

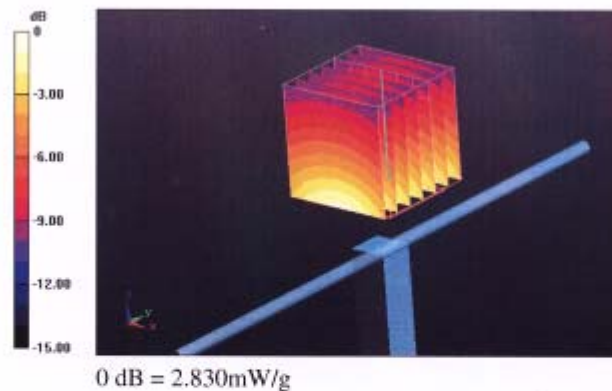
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.406 V/m; Power Drift = 0.02 dB

Peak SAR (extrapolated) = 3.509 W/kg

SAR(1 g) = 2.42 mW/g; SAR(10 g) = 1.59 mW/g

Maximum value of SAR (measured) = 2.827 mW/g

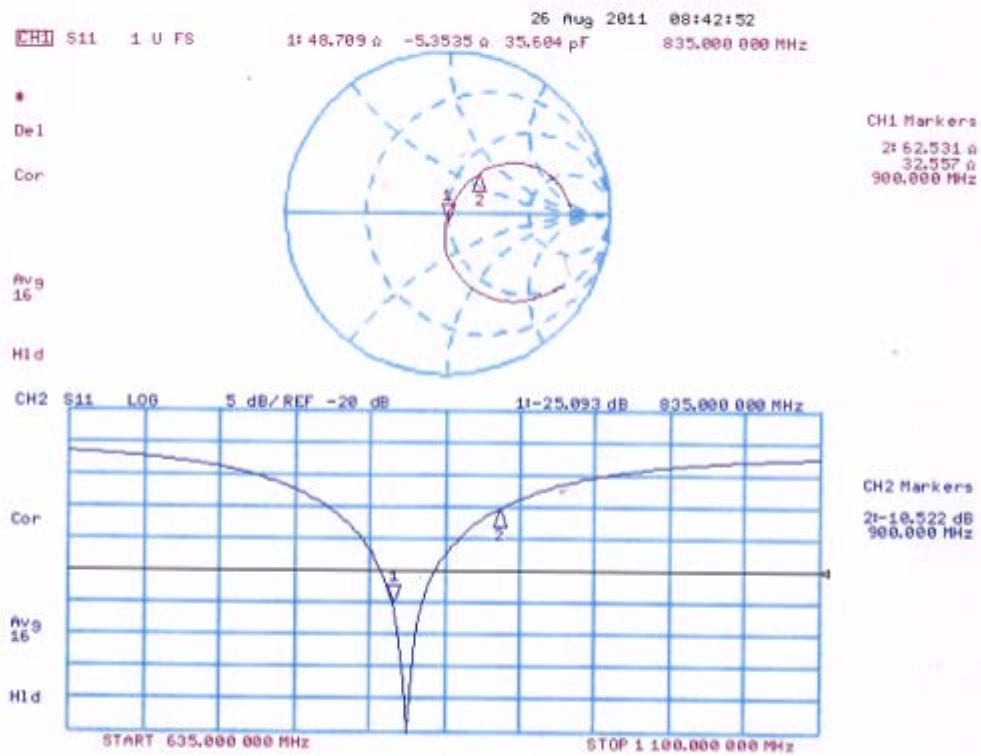


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Test Report

Report No. RXA1310-0177SAR

Page 54 of 64

Impedance Measurement Plot for Body TSL



TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1310-0177SAR

Page 55 of 64

ANNEX F: DAE4 Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TA Shanghai (Auden)

Certificate No: DAE4-1317_Jan13

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BJ - SN: 1317

Calibration procedure(s) QA CAL-06.v25
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: January 25, 2013

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	02-Oct-12 (No:12728)	Oct-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	07-Jan-13 (in house check)	In house check: Jan-14
Calibrator Box V2.1	SE UMS 006 AA 1002	07-Jan-13 (in house check)	In house check: Jan-14

Calibrated by:	Name R. Mayoraz	Function Technician	Signature
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Approved by:	Name Fin Bornholt	Function Deputy Technical Manager	Signature
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Issued: January 25, 2013

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Test Report

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Page 56 of 64

Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 57 of 64

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV
Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.011 $\pm$ 0.02% (k=2)	404.006 $\pm$ 0.02% (k=2)	403.901 $\pm$ 0.02% (k=2)
Low Range	3.98819 $\pm$ 1.55% (k=2)	3.99805 $\pm$ 1.55% (k=2)	3.98192 $\pm$ 1.55% (k=2)

Connector Angle

Connector Angle to be used in DASY system	117 ° $\pm$ 1 °
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TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 58 of 64

Appendix

1. DC Voltage Linearity

High Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	199994.16	-0.78	-0.00
Channel X + Input	20000.75	0.37	0.00
Channel X - Input	-19997.98	2.89	-0.01
Channel Y + Input	199995.20	0.02	0.00
Channel Y + Input	19999.08	-1.15	-0.01
Channel Y - Input	-20002.66	-1.66	0.01
Channel Z + Input	199994.67	-0.43	-0.00
Channel Z + Input	19997.92	-2.31	-0.01
Channel Z - Input	-20000.66	0.26	-0.00

Low Range	Reading (μV)	Difference (μV)	Error (%)
Channel X + Input	2001.23	0.59	0.03
Channel X + Input	201.53	0.55	0.28
Channel X - Input	-198.20	0.62	-0.31
Channel Y + Input	2000.33	-0.29	-0.01
Channel Y + Input	200.43	-0.68	-0.34
Channel Y - Input	-199.64	-0.69	0.35
Channel Z + Input	2000.78	0.22	0.01
Channel Z + Input	200.32	-0.69	-0.34
Channel Z - Input	-199.27	-0.35	0.18

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-23.69	-25.75
	- 200	28.59	26.45
Channel Y	200	-1.44	-1.70
	- 200	-0.06	-0.16
Channel Z	200	-10.76	-11.18
	- 200	9.82	9.91

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.52	-4.72
Channel Y	200	8.54	-	4.31
Channel Z	200	10.79	5.34	-

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1310-0177SAR

Page 59 of 64

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16104	15986
Channel Y	16111	15993
Channel Z	16217	16069

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	1.28	0.53	2.45	0.33
Channel Y	-1.29	-2.89	0.51	0.58
Channel Z	-0.39	-1.47	1.06	0.37

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

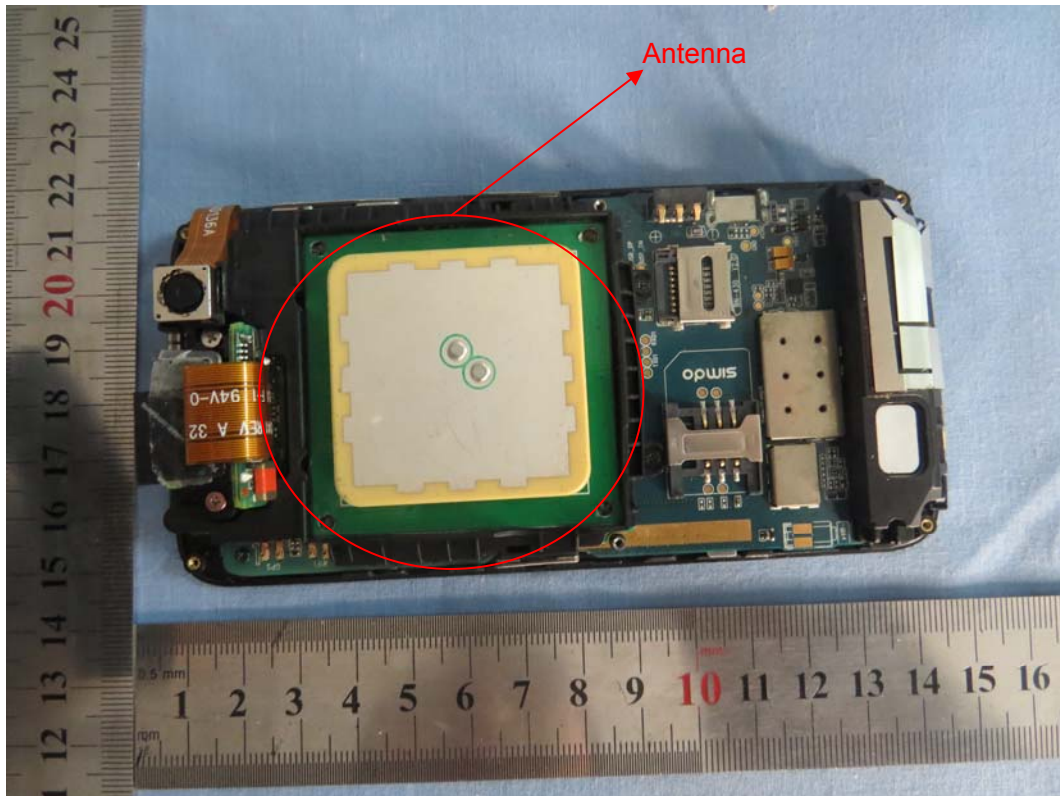
ANNEX G: The EUT Appearances and Test Configuration



a.EUT



b.Battery



c. Antenna Schemes(Back Side of EUT)

Picture 3: Constituents of the EUT



Picture 4: Test position 1



Picture 5: Test Position 2



Picture 6: Test Position 3



Picture 7: Test Position 4

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Test Report

Report No. RXA1310-0177SAR

Page 64 of 64



Picture 8: Test Position 5 (this position is not tested)